

6R190C6-VB TO247 Datasheet

N-Channel 650 V (D-S) Super Junction MOSFET

PRODUCT SUMMARY						
V _{DS} (V) at T _J max.	650					
R _{DS(on)} (Ω) at 25 °C	$V_{GS} = 10 V$	0.19				
Q _g max. (nC)	106					
Q _{gs} (nC)	14					
Q _{gd} (nC)	33					
Configuration	Single					

D **TO-247AC** G G S Top View N-Channel MOSFET

FEATURES

- Reduced t_{rr}, Q_{rr}, and I_{RRM}
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q_{rr}
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Lighting
 - High-intensity discharge (HID)
- Fluorescent ballast lighting
- Consumer and computing - ATX power supplies
- Industrial
 - Welding
 - Battery chargers
- Renewable energy
- Solar (PV inverters)
- Switch mode power supplies (SMPS)

= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			LIMIT	UNIT	
Drain-Source Voltage			650	V	
Gate-Source Voltage			± 30	V	
V _{GS} at 10 V	T _C = 25 °C	- I _D -	20		
	T _C = 100 °C		13	A	
Pulsed Drain Current ^a			53		
Linear Derating Factor			1.7	W/°C	
Single Pulse Avalanche Energy ^b			367	mJ	
Maximum Power Dissipation			208	W	
Operating Junction and Storage Temperature Range			-55 to +150	°C	
T _J = 125 °C		d\//dt	37	1//20	
Reverse Diode dV/dt ^d			31	V/ns	
for 10 s			300	°C	
	V _{GS} at 10 V e T _J = 1	$V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_{C} = 25 \text{ °C}}{T_{C} = 100 \text{ °C}}$ e $T_{J} = 125 \text{ °C}$	I_{DM} E_{AS} P_{D} $T_{J} = 125 \ ^{\circ}C$ dV/dt	$\begin{tabular}{ c c c c c } \hline $YMBOL$ $LIMIT$ \\ V_{DS} 650 \\ V_{GS} ± 30 \\ \hline I_{D} 13 \\ \hline I_{D} 13 \\ \hline I_{D} 53 \\ \hline I_{C} = 100 °C$ I_{D} 53 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 53 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 13 \\ \hline I_{C} = 100 °C$ I_{D} 13 \\ \hline I_{DM} 13 \\ \hline I_{C} = 100 °C$ I_{D} I_{D} \\ \hline I_{C} = 100 °C$ I_{D} I_{C} \\ \hline I_{C} = 100 °C$ I_{D} I_{C} I_{C} I_{C} \\ \hline I_{C} = 100 °C$ I_{D} I_{C}	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD} = 50$ V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 5.1 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D$, dl/dt = 100 A/µs, starting T_J = 25 °C.



PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		62				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.5				°C/W		
SPECIFICATIONS (T _J = 25 °C, u	nless otherw	ise noted)						
PARAMETER	SYMBOL		T CONDIT	IONS	MIN.	TYP.	MAX.	
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 1	250 µA	650	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference to 25 °C, $I_D = 1$ mA		-	0.67	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}		$V_{DS} = V_{GS}, I_D = 250 \ \mu\text{A}$		2	-	4	V
	0.0(0.1)	$V_{GS} = \pm 20 V$		-	-	± 100	nA	
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30 \text{ V}$		-	-	± 1	μA
Zero Gate Voltage Drain Current			$V_{\rm DS} = 520 \text{ V}, \text{ V}_{\rm GS} = 0 \text{ V}$		-	-	1	
	I _{DSS}			/, T _J = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		_D = 11 A	-	0.19	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D :	= 11 A	-	7.0	-	S
Dynamic		-				<u>.</u>		
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz $V_{DS} = 0 V \text{ to } 520 V, V_{GS} = 0 V$		-	2322	-	pF	
Output Capacitance	C _{oss}			-	105	-		
Reverse Transfer Capacitance	C _{rss}			-	4	-		
Effective Output Capacitance, Energy Related ^a	C _{o(er)}			-	84	-		
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	293	-		
Total Gate Charge	Qg	V _{GS} = 10 V I _D = 11 A, V _{DS} = 520 V			-	71	106	1
Gate-Source Charge	Q _{gs}			-	14	-	nC	
Gate-Drain Charge	Q _{gd}				-	33	-	1
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 520 \text{ V}, \text{ I}_{D} = 11 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$		-	22	44	- ns	
Rise Time	t _r			-	34	68		
Turn-Off Delay Time	t _{d(off)}			-	68	102		
Fall Time	t _f			-	42	84		
Gate Input Resistance	Rg	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characteristic								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	21	- A	
Pulsed Diode Forward Current	I _{SM}			-	-	53		
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 11 A, V _{GS} = 0 V		-	0.9	1.2	V	
Reverse Recovery Time	t _{rr}				-	160	-	ns
Reverse Recovery Charge	Q _{rr}	T _J = 25 °C, I _F = I _S = 11 A, dl/dt = 100 A/μs, V _R = 25 V		-	1.2	-	μC	
Reverse Recovery Current	I _{RRM}			-	14	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

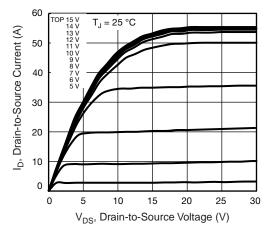


Fig. 1 - Typical Output Characteristics

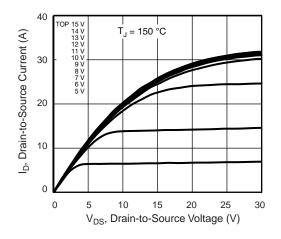


Fig. 2 - Typical Output Characteristics

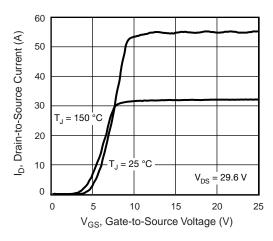


Fig. 3 - Typical Transfer Characteristics

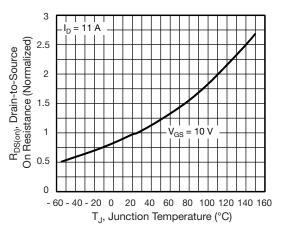


Fig. 4 - Normalized On-Resistance vs. Temperature

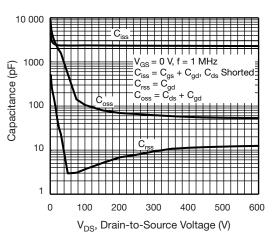


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

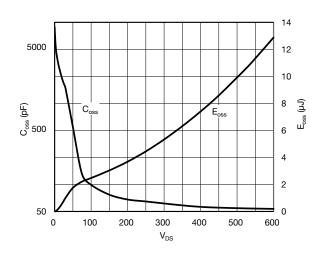


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}

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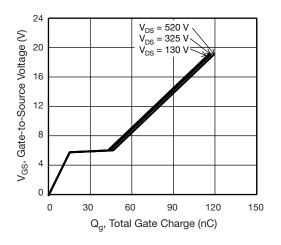


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

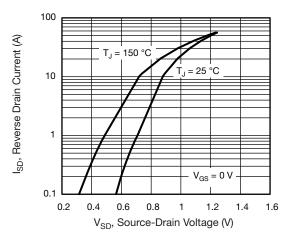


Fig. 8 - Typical Source-Drain Diode Forward Voltage

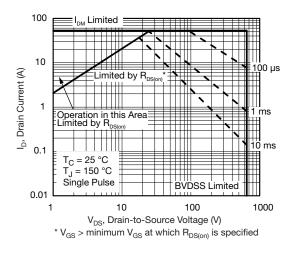


Fig. 9 - Maximum Safe Operating Area

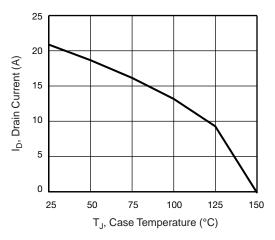


Fig. 10 - Maximum Drain Current vs. Case Temperature



Fig. 11 - Temperature vs. Drain-to-Source Voltage



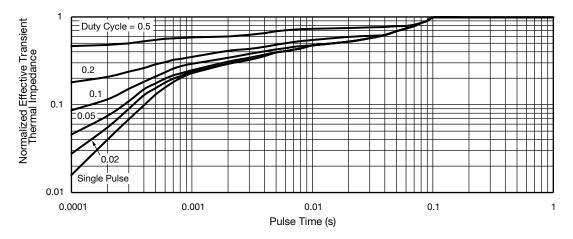


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

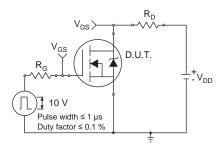


Fig. 13 - Switching Time Test Circuit

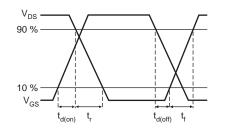


Fig. 14 - Switching Time Waveforms

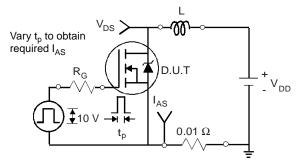


Fig. 15 - Unclamped Inductive Test Circuit

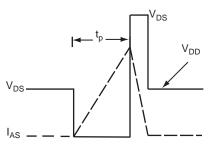


Fig. 16 - Unclamped Inductive Waveforms

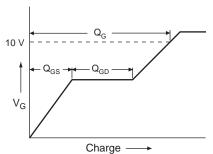


Fig. 17 - Basic Gate Charge Waveform

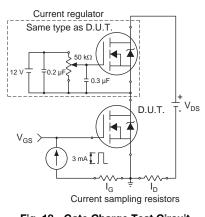
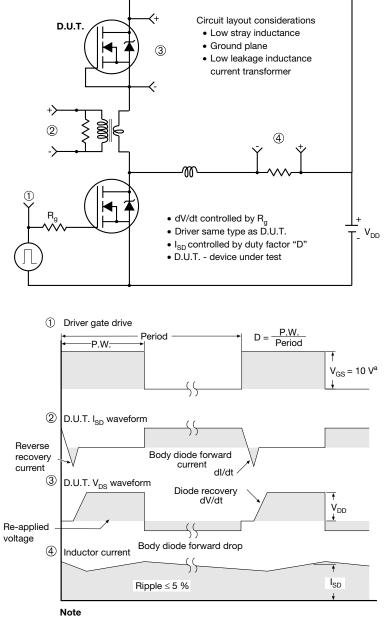


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5$ V for logic level devices

Fig. 19 - For N-Channel



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